

| Project Number: Severe Environment Test Report | Tracking Code: 1726516_Report_Rev_1 |
|--|-------------------------------------|
| Requested by: Mark Shireman | Date: 8/14/2019 |
| Part #: SFM-150-02-S-D/TFM-150-02-S-D | |
| Part description: SFM/TFM | Tech: Tony Wagoner |
| Test Start: 2/12/2019 | Test Completed: 4/18/2019 |





SEVERE ENVIRONMENT TEST REPORT SFM/TFM SFM-150-02-S-D/TFM-150-02-S-D

| Tracking Code: 1726516_Report_Rev_1 | Part #: SFM-150-02-S-D/TFM-150-02-S-D | | | | |
|-------------------------------------|---------------------------------------|--|--|--|--|
| Part description: SFM/TFM | | | | | |

REVISION HISTORY

| DATA | REV.NUM. | DESCRIPTION | ENG |
|-----------|----------|---------------|-----|
| 8/14/2019 | 1 | Initial Issue | KH |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

All contents contained herein are the property of Samtec. No portion of this report, in part or in full shall be reproduced without prior written approval of Samtec.

SCOPE

To perform the following tests: Severe Environment test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364; VITA 47.1

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead Free
- 9) Samtec Test PCBs used: PCB-109461-TST/ PCB-109718-TST

FLOWCHARTS

Mating/Unmating/Durability

Note: With Humidity (Up to 100% RH, 240 hours, 25°C to 65°C) Note: From MIL-STD-810G: For chamber control purposes, 100% RH implies as close to 100% RH as possible, but not less than 95%.

| | <u>Group 1</u> | | <u>Group 2</u> | | Group 3 | |
|------------------------------|--|----------------------------------|---------------------------|----------------|---------------------------|---|
| SFM-150-02-S-D | | | SFM-125-02-S-D | SFM-105-02-S-D | | |
| | TFM-150-02-S-D | | TFM-125-02-S-D | | TFM-105-02-S-D | |
| 8 Assemblies | | | 8 Assemblies | | 8 Assemblies | |
| | 50 Positions | | 25 Positions | 5 Positions | | |
| Step | Description | Step | Description | Step | Description | |
| 1. | LLCR (2) | 1. | Mating/Unmating Force (3) | 1. | Mating/Unmating Force (3) | |
| 2. | Mating/Unmating Force (3) | 2. | Cycles | 2. | Cycles | |
| 3. | Cycles | | Quantity = 250 Cycles | | Quantity = 250 Cycles | |
| | Quantity = 250 Cycles | 3. | Mating/Unmating Force (3) | 3. | Mating/Unmating Force (3) | |
| 4. | LLCR (2) Max Delta = 15 mOhm | | | | | |
| 5. | Thermal Shock (4) | | | | | |
| 6. | LLCR (2) Max Delta = 15 mOhm | | | | | |
| 7. | Humidity (1) - Non Standard | | | | | |
| 8. | LLCR (2) Max Delta = 15 mOhm | | | | | |
| | Max Delta - 15 momm | | | | | |
| 9. 1) Hum | Mating/Unmating Force (3) idity = Other 240 Hours | | | | | - |
| l) Hum | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to |) 100% RH | | | | |
| l) Hum | idity = Other 240 Hours | | | | | - |
| 2) LLCR | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV N | | | | | |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max | ax Extremes = .5°C to +85° | | | | _ |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max ng/Unmating Force = EIA-364-13 mal Shock = EIA-364-32 Exposure Time at Temperature Method A, Test Condition = I (-5 | ax Extremes = .5°C to +85° | | | | |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max ng/Unmating Force = EIA-364-13 mal Shock = EIA-364-32 Exposure Time at Temperature Method A, Test Condition = I (-5 | ax Extremes = .5°C to +85° | | | | |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max ng/Unmating Force = EIA-364-13 mal Shock = EIA-364-32 Exposure Time at Temperature Method A, Test Condition = I (-5 | ax Extremes = .5°C to +85° | | | | |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max ng/Unmating Force = EIA-364-13 mal Shock = EIA-364-32 Exposure Time at Temperature Method A, Test Condition = I (-5 | ax Extremes = .5°C to +85° | | | | - |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max ng/Unmating Force = EIA-364-13 mal Shock = EIA-364-32 Exposure Time at Temperature Method A, Test Condition = I (-5 | ax Extremes = .5°C to +85° | | | | |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max ng/Unmating Force = EIA-364-13 mal Shock = EIA-364-32 Exposure Time at Temperature Method A, Test Condition = I (-5 | ax Extremes = .5°C to +85° | | | | - |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max ng/Unmating Force = EIA-364-13 mal Shock = EIA-364-32 Exposure Time at Temperature Method A, Test Condition = I (-5 | ax Extremes = .5°C to +85° | | | | - |
| 2) Hum 2) LLCR 3) Mati | idity = Other 240 Hours +25°C to +65°C @ 95% RH up to = EIA-364-23 Open Circuit Voltage = 20 mV M Test Current = 100 mA Max ng/Unmating Force = EIA-364-13 mal Shock = EIA-364-32 Exposure Time at Temperature Method A, Test Condition = I (-5 | ax Extremes = .5°C to +85° | | | | - |

FLOWCHARTS Continued

Mechanical Shock/Random Vibration/LLCR

| SFM-150-02-S-D TFM-150-02-S-D 8 Assem blies VITA 47.1 (V To V) | | | SFM-150-02-S-D TFM-150-02-S-DH 8 Assemblies VITA 47.1 (DH To V) |
|---|--|------|--|
| Step | Description | Step | Description |
| 1. | LLCR (1) | 1. | LLCR (1) |
| 2. | Mechanical Shock (2) - Non Standard | 2. | Mechanical Shock (2) - Non Standard |
| 3. | Random Vibration (3) - Non Standard Note: Conditions: 1) 5 Hz to 100 Hz, PSD increasing at 3dB/octave 2) 100 Hz to 1000 Hz 0.10 g^2/Hz 3) 1000 Hz to 2000 HzPSD decreasing at 3dB/octave | 3. | Random Vibration (3) - Non Standard Note: Conditions: 1) 5 Hz to 100 Hz, PSD increasing at 3 dB/octave 2) 100 Hz to 1000 Hz 0.10 g^2/Hz 3) 1000 Hz to 2000 HzPSD decreasing at 3 dB/octave |
| 4. | LLCR (1) Max Delta = 15 mOhm | 4. | LLCR (1) Max Delta = 15 mOhm |
| 1) LLCR | = EIA-364-23 Open Circuit Voltage = 20 mV Max Test Current = 100 mA Max | к | |

40G, 11 milliseconds, Half Sine Number of Shocks = 3 Per Direction, Per Axis, 18 Total Operating Shock Class OS2

(3) Random Vibration = Other 12 G 'RMS', 5Hz to 2000Hz, 1 Hours/Axis Vibration Class V3 VITA 47.1

Mechanical Shock/Random Vibration/Event Detection

| | Group 1 | | Group 2 |
|------|--|------|--|
| | SFM-150-02-S-D | | SFM-150-02-S-D |
| | TFM-150-02-S-D | | TFM-150-02-S-DH |
| | 8 Assemblies | | 8 Assemblies |
| | VITA 47.1 (V To V) | | VITA 47.1 (DH To V) |
| Step | Description | Step | Description |
| 1. | Nanosecond Event Detection (Mechanical Shock) (1) - Non Standard | 1. | Nanosecond Event Detection (Mechanical Shock) (1) - Non Standard |
| 2. | Nanosecond Event Detection (Random Vibration) (2) - Non Standard Note: Conditions: 1) 5 Hz to 100 Hz, PSD increasing at 3dB/octave 2) 100 Hz to 1000 Hz 0.10 g^2/Hz 3) 1000 Hz to 2000 HzPSD decreasing at 3dB/octave | 2. | Nanosecond Event Detection (Random Vibration) [2] - Non Standard Note: Conditions: 1) 5 Hz to 100 Hz, PSD increasing at 3dB/octave 2) 100 Hz to 1000 Hz 0.10 g^2/Hz 3) 1000 Hz to 2000 HzPSD decreasing at 3dB/octave |

 Nanosecond Event Detection (Mechanical Shock) = Other Use EIA-364-87 for Nanosecond Event Detection: Test Condition = F (50 nanoseconds at 10 ohms) 40G, 11 milliseconds, Half Sine

(2) Nanosecond Event Detection (Random Vibration) = Other

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms) Random Vibration: 12 G 'RMS', 5Hz to 2000Hz, 1 Hours/Axis, Vibration Class V3 VITA 47.1

FLOWCHARTS Continued

Temperature Cycling

Group 1

SFM-150-02-S-D

TFM-150-02-S-D

8 Assemblies

500 Thermal Cycles

Note: Reference MIL-STD-202G, Method 107, Thermal Shock

Step Description

1. Continuity (Initial)

- Temperature Cycles (1) Non Standard Cycles = 500 Cycles Continuity = Monitor for 1 MicroSecond Interruptions Throughout
- Continuity (Following Last Cycle)

 (1) Temperature Cycles = Other Max Temperature = 125° C Min Temperature = -65° C Dwell Time = 30 minutes at each extreme Ramp Rate = 10° C/min VITA 47.1

Non-Operating Class Temperature

VITA 47.1

Group 1 SFM-150-02-S-D TFM-150-02-S-D 8 Assem blies

Non-Operating Class Temperature

Step Description

- 1. LLCR (1) Max Delta = 15 mOhm
- Temperature Cycle Cycles = 100 Temperature Cycle = -55°C to 105°C
- LLCR (1) Max Delta = 15 mOhm
- Temperature Cycle Cycles = 100 Temperature Cycles = -65°C to 125°C
- 5. LLCR (1)

Max Delta = 15 mOhm

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max Test Current = 100 mA Max

FLOWCHARTS Continued

DWV @ Altitude

<u>Pin to Pin</u>

Group 1 SFM-150-02-S-D TFM-150-02-S-D 3 Assemblies Custom Group

Step Description

1. DWV at Test Voltage (1) - Non Standard Note: Test Voltage to be 300 VAC

Row to Row

<u>Group 2</u> SFM-150-02-S-D TFM-150-02-S-D 3 Assemblies Custom Group

Step Description

 DWV at Test Voltage (2) - Non Standard Note: Test Voltage to be 300 VAC

DWV at Test Voltage = Other
 Test Condition IV= 70,000 ft
 DWV test voltage is equal to 75% of the lowest breakdown voltage
 Test voltage applied for 60 seconds

 DWV at Test Voltage = Other
 Test Condition IV= 70,000 ft

DWV test voltage is equal to 75% of the lowest breakdown voltage Test voltage applied for 60 seconds

Electrostatic Discharge (ESD)

<u>Group 1</u> SFM-150-02-S-D TFM-150-02-S-D 8 Assem blies EN61000-4-2

Step Description

1. Exposure To 5kV, 10kV, 15kV, Repeat 10 Times Note: The connector shall not be susceptable to damage by ESD events from 0 to 15kV as discharged from a 150 pf capacitor through a 330 ohm resistor.

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

TEMPERATURE CYCLES:

- 1) OTHER, Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors.
- 2) Test Condition: -65° C to $+125^{\circ}$ C.
- 3) Test Time: $\frac{1}{2}$ hour dwell at each temperature extreme.
- 4) Test Duration: 500 Cycles
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

TEMPERATURE CYCLES:

- 7) OTHER, Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors.
- 8) Test Condition: -55° C to $+105^{\circ}$ C and -65° C to $+125^{\circ}$ C.
- 9) Test Time: $\frac{1}{2}$ hour dwell at each temperature extreme.
- 10) Test Duration:100 Cycles
- 11) All test samples are pre-conditioned at ambient.
- 12) All test samples are exposed to environmental stressing in the mated condition.

THERMAL SHOCK:

1) EIA-364-32, Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors.

- 2) Test Condition I: -55° C to $+85^{\circ}$ C.
- 3) Test Time: $\frac{1}{2}$ hour dwell at each temperature extreme.
- 4) Test Duration: A-3 100 Cycles
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: Other, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition, 240 Hours.
- 3) Method, $+25^{\circ}$ C to $+65^{\circ}$ C, 95% to 100% Relative Humidity excluding sub-cycles 7a.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MATING/UNMATING:

- 1) Reference document: EIA-364-13, Mating and Unmating Forces Test Procedure for Electrical Connectors.
- 2) The full insertion position was to within 0.003" to 0.004" of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: other, Mechanical Shock Test Procedure for Electrical Connectors
- 2) Test Condition: OS2
- 3) Peak Value: 40 G
- 4) Duration: 11 Milliseconds
- 5) Wave Form: Half Sine
- 6) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

- 1) Reference document: other, Vibration Test Procedure for Electrical Connectors
- 2) Test Condition: V3 vita 47.1.
- 3) Power Spectral Density: 0.04 G² / Hz
- 4) G 'RMS': 12
- 5) Frequency: 5 to 2000 Hz
- 6) Duration: 1 Hours per axis (3 axis total)

| Tracking Code: 1726516_Report_Rev_1 | Part #: SFM-150-02-S-D/TFM-150-02-S-D |
|-------------------------------------|---------------------------------------|
| P | |

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

NANOSECOND-EVENT DETECTION:

- 1) Reference document: EIA-364-87, Nanosecond-Event Detection for Electrical Connectors
- 2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
- 3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

LLCR:

- 1) EIA-364-23, Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. <= +5.0 mOhms: -----Stable
 - b. +5.1 to +10.0 mOhms:-----Minor
 - c. +10.1 to +15.0 mOhms: -----Acceptable
 - d. +15.1 to +50.0 mOhms: -----Marginal
 - e. +50.1 to +2000 mOhms: -----Unstable
 - f. >+2000 mOhms:-----Open Failure

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

- 1) **PROCEDURE**:
 - a. Reference document: other, Withstanding Voltage Test Procedure for Electrical Connectors.
 - b. Test Conditions IV=70000 ft
 - c. Test voltage applied for 60 seconds.

ELECTROSTATIC DISCHARGE:

- 1) Reference Document: EN61000-4-2, VITA 47
- 2) Connector shall not be susceptible to damage by electrostatic discharge (ESD) events from 0 to 15kV as discharged from a 150-pf capacitor through a 330-ohm resistor.
- 3) Any damage shall be noted.

| | | | RESULTS |
|-------|----------|-------------|---|
| Matir | ng – Um | mating | Forces |
| | 0 | 0 | ability Group (SFM-150-02-S-D/TFM-150-02-S-D) |
| • | Initial | ung Dui | |
| | 0 | Mating | |
| | | • | Min18.13 lbs |
| | | • | Max22.22 lbs |
| | 0 | Unmati | 8 |
| | | • | Min13.27 lbs |
| | | • | Max18.17 lbs |
| • | After 2 | 50 Cycles | 8 |
| | 0 | Mating | Min 20 (4 lbs |
| | | | Min20.64 lbs Max25.95 lbs |
| | 0 | • Unmoti | |
| | 0 | Unmati | Min14.83 lbs |
| | | | Max21.69 lbs |
| • | After F | Iumidity | #16U/ 100 |
| | 0 | Mating | |
| | - | • | Min12.14 lbs |
| | | • | Max16.59 lbs |
| | 0 | Unmati | ng |
| | | • | Min 9.54 lbs |
| | | • | Max14.84 lbs |
| Mati | ing Unma | ating Bas | ic Group (SFM-125-02-S-D/TFM-125-02-S-D) |
| • | Initial | 8 | |
| | 0 | Mating | |
| | | • | Min10.36 lbs |
| | | • | Max13.18 lbs |
| | 0 | Unmati | |
| | | • | Min10.11 lbs |
| | | | Max11.43 lbs |
| • | | 50 Cycles | 8 |
| | 0 | Mating | Min 10.07 II |
| | | | Min12.37 lbs Max15.57 lbs |
| | 0 | - Unmati | |
| | 0 | Unnau | Min10.82 lbs |
| | | | Max13.26 lbs |
| | • • | /• • • | |
| Mat | | ating Bas | ic Group (SFM-105-02-S-D/TFM-105-02-S-D) |
| • | Initial | M-4 | |
| | 0 | Mating | Min 1.00 lba |
| | | - | Min 1.90 lbs Max 2.64 lbs |
| | 0 | - Unmati | |
| | 0 | Unnau • | Min 1.72 lbs |
| | | | Max 2.33 lbs |
| • | After 2 | 50 Cycles | |
| | 0 | Mating | - |
| | - | • | Min 2.25 lbs |
| | | • | Max2.38 lbs |
| | 0 | Unmati | 0 |
| | | • | Min 1.92 lbs |
| | | • | Max 2.35 lbs |
| | | | |

RESULTS Continued

Temperature Cycling

Continuity Initial

No Interruptions ------Passed

Continuity Following 500 Cycles

No Interruptions ------Passed

DWV @ Altitude

• Minimums

Test Voltage ------300 VAC
 Altitude Tested ------70000 ft.

Pin to Pin

| • | DWVPasse | ed |
|----|----------|----|
| Ro | w to Row | |

• DWV-----Passed

Electrostatic Discharge

| 5K V |
|-----------------|
| No DamagePassed |
| 10kV |
| No DamagePassed |
| 15kV |
| No DamagePassed |

RESULTS Continued

LLCR Mating Unmating Durability Group (192 LLCR test points)

- Initial ------8.49 mOhms Max
 - **Durability**, 250 Cycles • <= +5.0 mOhms ------ 192 Points ------ Stable 0 +5.1 to +10.0 mOhms ------ 0 Points ----- Minor 0 +10.1 to +15.0 mOhms ------ 0 Points ------ Acceptable 0 +15.1 to +50.0 mOhms ------ Marginal 0 +50.1 to +1000 mOhms------- 0 Points ------ Unstable 0 >+1000 mOhms------ Open Failure 0 **Thermal Shock** <= +5.0 mOhms ------ 192 Points ------ Stable 0 +5.1 to +10.0 mOhms ------ Minor 0 +10.1 to +15.0 mOhms ------ 0 Points ------ Acceptable 0 +15.1 to +50.0 mOhms ------ 0 Points ------ Marginal 0 +50.1 to +1000 mOhms------- 0 Points ------ Unstable 0 >+1000 mOhms------ Open Failure 0 Humidity <= +5.0 mOhms ------ 192 Points ------ Stable 0 +5.1 to +10.0 mOhms ------ 0 Points ----- 0 Minor 0 +10.1 to +15.0 mOhms ------ 0 Points ------ Acceptable 0 +15.1 to +50.0 mOhms ------ Marginal 0 +50.1 to +1000 mOhms------ 0 Points ------ Unstable 0 >+1000 mOhms------ Open Failure 0

RESULTS Continued LLCR Vibration and Mechanical Shock Group (192 LLCR test points) Group 1 SFM-150-02-S-D/TFM-150-02-S-D (V to V) Initial -----8.66 mOhms Max Shock and Vibe <= +5.0 mOhms ------ 192 Points ------ Stable \circ +5.1 to +10.0 mOhms ------ 0 Points ------ Minor \cap +10.1 to +15.0 mOhms ------ 0 Points ------ Acceptable 0 +15.1 to +50.0 mOhms ------ 0 Points ------ Marginal 0 +50.1 to +1000 mOhms------- 0 Points ------ Unstable \cap >+1000 mOhms------ Open Failure **Mechanical Shock & Random Vibration:** Shock 0 No Damage----- Pass 50 Nanoseconds----- Pass Vibration 0 No Damage----- Pass 50 Nanoseconds------ Pass Group 2 SFM-150-02-S-D/TFM-150-02-S-DH (DH to V) Row 1 Initial ------ 12.23 mOhms Max Shock and Vibe <= +5.0 mOhms ------ 92 Points ------ Stable 0 +5.1 to +10.0 mOhms ------ Minor 0 +10.1 to +15.0 mOhms ------ 0 Points ------ Acceptable 0 +15.1 to +50.0 mOhms ------ 0 Points ------ Marginal 0 0 >+1000 mOhms------ Open Failure \cap Row 2 Initial ----- 12.81 mOhms Max Shock and Vibe <= +5.0 mOhms ------ 95 Points ------ Stable 0 +5.1 to +10.0 mOhms ------ 1 Points ------ Minor 0 +10.1 to +15.0 mOhms ------ 0 Points ------ Acceptable 0 +15.1 to +50.0 mOhms ------ 0 Points ------ Marginal \cap \circ >+1000 mOhms------ Open Failure 0 **Mechanical Shock & Random Vibration:** Shock 0 No Damage----- Pass 50 Nanoseconds------ Pass . Vibration 0 No Damage----- Pass 50 Nanoseconds------ Pass

RESULTS Continued

LLCR Non-Operating Class Temperature Group (192 LLCR test points)

- Initial -----9.97 mOhms Max
 - Temperature Cycle1 (-55°C to +105°C)

٠

| rempe | | | |
|-------|---------------------------------|------------|--------------|
| 0 | <= +5.0 mOhms | 192 Points | Stable |
| 0 | +5.1 to +10.0 mOhms | 0 Points | Minor |
| 0 | +10.1 to +15.0 mOhms | 0 Points | Acceptable |
| 0 | +15.1 to +50.0 mOhms | 0 Points | Marginal |
| 0 | +50.1 to +1000 mOhms | 0 Points | Unstable |
| 0 | >+1000 mOhms | 0 Points | Open Failure |
| Tempe | rature Cycle2 (-65°C to +125°C) | | |
| 0 | <= +5.0 mOhms | 192 Points | Stable |
| 0 | +5.1 to +10.0 mOhms | 0 Points | Minor |
| 0 | +10.1 to +15.0 mOhms | 0 Points | Acceptable |
| 0 | +15.1 to +50.0 mOhms | 0 Points | Marginal |
| 0 | +50.1 to +1000 mOhms | 0 Points | Unstable |
| 0 | >+1000 mOhms | 0 Points | Open Failure |

DATA SUMMARIES

MATING/UNMATING: Mating Unmating Durability Group SFM-150-02-S-D/TFM-150-02-S-D

| | Initial | | | | 250 Cycles | | | |
|---------|---------------------|-------|----------|-------------|------------|-------------|---------|-------------|
| | M | ating | Unmating | | Mating | | Unr | nating |
| | Newtons Force (Lbs) | | Newtons | Force (Lbs) | Newtons | Force (Lbs) | Newtons | Force (Lbs) |
| Minimum | 80.66 | 18.13 | 59.02 | 13.27 | 91.82 | 20.64 | 65.94 | 14.83 |
| Maximum | 98.83 | 22.22 | 80.80 | 18.17 | 115.40 | 25.95 | 96.48 | 21.69 |
| Average | 86.70 | 19.49 | 73.14 | 16.44 | 103.76 | 23.33 | 86.89 | 19.53 |
| St Dev | 7.12 | 1.60 | 7.51 | 1.69 | 7.88 | 1.77 | 10.17 | 2.29 |
| Count | 8 | 8 | 8 | 8 | 8 | 8 | 8 | 8 |
| | | | | | | | | |

| | After Humidity | | | | |
|---------|----------------|-------------|----------|-------------|--|
| | Μ | ating | Unmating | | |
| | Newtons | Force (Lbs) | Newtons | Force (Lbs) | |
| Minimum | 53.99 | 12.14 | 42.43 | 9.54 | |
| Maximum | 73.79 | 16.59 | 65.99 | 14.84 | |
| Average | 62.05 | 13.95 | 53.10 | 11.94 | |
| St Dev | 6.33 | 1.42 | 7.17 | 1.61 | |
| Count | 8 | 8 | 8 | 8 | |

Mating Unmating Basic Group SFM-125-02-S-D/TFM-125-02-S-D

| | Initial | | | | 250 Cycles | | | |
|---------|---------|-------------|---------|-------------|------------|-------------|---------|-------------|
| | Μ | ating | Uni | mating | Mating | | Un | mating |
| | Newtons | Force (Lbs) | Newtons | Force (Lbs) | Newtons | Force (Lbs) | Newtons | Force (Lbs) |
| Minimum | 46.08 | 10.36 | 44.96 | 10.11 | 55.03 | 12.37 | 48.13 | 10.82 |
| Maximum | 58.62 | 13.18 | 50.83 | 11.43 | 69.26 | 15.57 | 58.99 | 13.26 |
| Average | 53.34 | 11.99 | 47.19 | 10.61 | 65.43 | 14.71 | 54.18 | 12.18 |
| St Dev | 3.95 | 0.89 | 2.25 | 0.51 | 4.65 | 1.05 | 3.49 | 0.79 |
| Count | 8 | 8 | 8 | 8 | 8 | 8 | 8 | 8 |

SFM-105-02-S-D/TFM-105-02-S-D

| | Inițial | | | | 250 Cycles | | | |
|---------|---------|-------------|----------|-------------|------------|-------------|----------|-------------|
| | Μ | ating | Unmating | | М | ating | Unmating | |
| | Newtons | Force (Lbs) | Newtons | Force (Lbs) | Newtons | Force (Lbs) | Newtons | Force (Lbs) |
| Minimum | 8.46 | 1.90 | 7.65 | 1.72 | 10.00 | 2.25 | 8.53 | 1.92 |
| Maximum | 11.73 | 2.64 | 10.37 | 2.33 | 10.58 | 2.38 | 10.47 | 2.35 |
| Average | 9.96 | 2.24 | 9.05 | 2.03 | 10.25 | 2.30 | 9.39 | 2.11 |
| St Dev | 1.06 | 0.24 | 0.94 | 0.21 | 0.17 | 0.04 | 0.69 | 0.15 |
| Count | 8 | 8 | 8 | 8 | 8 | 8 | 8 | 8 |

DATA SUMMARIES Continued

Temperature Cycling

| Tem | Temperature Cycling Event Detection Summary | | | |
|-----------------|---|--|--|--|
| Contacts tested | 800 | | | |
| Test Conditions | Continuity (Monitor for 1 Microsecond Interruptions Throughout) | | | |
| Temperature | Min Temp = -65°C / Max Temp = 125°C | | | |
| Dwell Time | 30 Minutes at each Extreme | | | |
| Ramp Rate | 10°C/min | | | |
| Total Events | 0 | | | |

DWV @ Altitude

| Altitude Tested = 70,000 feet | | | |
|-------------------------------|------------|--|--|
| Test Voltage= 300 | | | |
| Pin to Pin | Row to Row | | |
| Mated | Mated | | |
| Passed | Passed | | |
| Passed | Passed | | |
| Passed | Passed | | |

Electrostatic Discharge

| Ele | Electrostatic Discharge (ESD) Summary | | | |
|-------------------|---|--|--|--|
| Assemblies tested | 8 | | | |
| Test Conditions | Exposure to 5kV, 10kV, and 15kV (Repeated 10 Times) | | | |
| 5kV | No Damage | | | |
| 10kV | No Damage | | | |
| 15kV | No Damage | | | |
| Pass/Fail | Pass | | | |

DATA SUMMARIES Continued

LLCR Mating Unmating Durability Group:

- 1) A total of 192 points were measured.
- 2) EIA-364-23, Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. <= +5.0 mOhms: -----Stable
 - b. +5.1 to +10.0 mOhms: -----Minor
 - c. +10.1 to +15.0 mOhms:-----Acceptable
 - d. +15.1 to +50.0 mOhms:-----Marginal
 - e. +50.1 to +1000 mOhms------Unstable
 - f. >+1000 mOhms:-----Open Failure

| | LLCR Measurement Summaries by Pin Type | | | | | |
|-------------------|--|-----------------|-----------------|-----------------|--|--|
| Date | 2/12/2019 | 2/12/2019 | 2/20/2019 | 3/11/2019 | | |
| Room Temp (Deg C) | 23 | 23 | 22 | 22 | | |
| Rel Humidity (%) | 45 | 43 | 32 | 35 | | |
| Technician | Tony Wagoner | Tony Wagoner | Tony Wagoner | Tony Wagoner | | |
| mOhm values | Actual | Delta | Delta | Delta | | |
| | Initial | 250 Cycles | Therm Shck | Humidity | | |
| | | Pin Type | 1: Signal | | | |
| Average | 7.35 | 0.41 | 0.85 | 0.91 | | |
| St. Dev. | 0.37 | 0.44 | 0.77 | 0.88 | | |
| Min | 6.46 | 0.00 | 0.00 | 0.01 | | |
| Max | 8.49 | 2.29 | 2.92 | 3.51 | | |
| Summary Count | 192 | 192 | 192 | 192 | | |
| Total Count | 192 | 192 | 192 | 192 | | |

| | LLCR Delta Count by Category | | | | | | | |
|------------|--|-------------|--------------|-------------|--------------|-------|--|--|
| | Stable Minor Acceptable Marginal Unstable Open | | | | | | | |
| mOhms | <=5 | >5 & <=10.0 | >10.1 & <=15 | >15.1& <=50 | >50 & <=1000 | >1000 | | |
| 250 Cycles | 192 | 0 | 0 | 0 | 0 | 0 | | |
| Therm Shck | 192 | 0 | 0 | 0 | 0 | 0 | | |
| Humidity | 192 | 0 | 0 | 0 | 0 | 0 | | |

DATA SUMMARIES Continued

LLCR Vibration and Mechanical Shock Group:

- 1) A total of 192 points were measured.
- 2) EIA-364-23, Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. <= +5.0 mOhms: -----Stable
 - b. +5.1 to +10.0 mOhms: -----Minor
 - c. +10.1 to +15.0 mOhms:-----Acceptable
 - d. +15.1 to +50.0 mOhms:-----Marginal
 - e. +50.1 to +1000 mOhms------Unstable
 - f. >+1000 mOhms:-----Open Failure

Group 1 SFM-150-02-S-D/TFM-150-02-S-D (V to V)

| | LLCR Measur | Pin Type |) | |
|-------------------|----------------|-------------------|-------|-------|
| Date | 3/26/2019 | 3/28/2019 | | |
| Room Temp (Deg C) | 23 | 22 | | |
| Rel Humidity (%) | 34 | 35 | | |
| Technician | Joe Schoettmer | Joe Schoettmer | | |
| mOhm values | Actual | Delta | Delta | Delta |
| | Initial | Shock-Vib | | |
| | Pi | in Type 1: Signal | | |
| Average | 7.51 | 0.11 | | |
| St. Dev. | 0.41 | 0.13 | | |
| Min | 6.76 | 0.00 | | |
| Max | 8.66 | 0.70 | | |
| Summary Count | 192 | 192 | | |
| Total Count | 192 | 192 | | |

| | LLCR Delta Count by Category | | | | | | | |
|--|------------------------------|-------------|--------------|-------------|--------------|-------|--|--|
| Stable Minor Acceptable Marginal Unstable Open | | | | | | | | |
| mOhms | <=5 | >5 & <=10.0 | >10.1 & <=15 | >15.1& <=50 | >50 & <=1000 | >1000 | | |
| Shock-Vib | 192 | 0 | 0 | 0 | 0 | 0 | | |

Nanosecond Event Detection:

| Shock and Vibration | Shock and Vibration Event Detection Summary | | | | |
|---------------------|---|--|--|--|--|
| Contacts tested | 60 | | | | |
| Test Condition | F, 40g's, 11ms, Half-Sine | | | | |
| Shock Events | 0 | | | | |
| Test Condition | V3 VITA 47.1, 12 G 'RMS', 5Hz to 2000Hz | | | | |
| Vibration Events | 0 | | | | |
| Total Events | 0 | | | | |

DATA SUMMARIES Continued

Group 1 SFM-150-02-S-D/TFM-150-02-S-DH (DH to V)

| | LLCR Measurement Summaries by Pin Type | | | | |
|-------------------|--|-----------------|-------|-------|--|
| Date | 4/16/2019 | 4/18/2019 | | | |
| Room Temp (Deg C) | 23 | 23 | | | |
| Rel Humidity (%) | 34 | 46 | | | |
| Technician | Joe Schoettmer | Tony Wagoner | | | |
| mOhm values | Actual | Delta | Delta | Delta | |
| | Initial | Shock-Vib | | | |
| | Pi | n Type 1: Row 1 | | | |
| Average | 9.51 | 2.05 | | | |
| St. Dev. | 0.89 | 1.63 | | | |
| Min | 8.09 | 0.04 | | | |
| Max | 12.23 | 8.64 | | | |
| Summary Count | 96 | 96 | | | |
| Total Count | 96 | 96 | | | |
| | Pi | n Type 2: Row 2 | | | |
| Average | 10.23 | 1.49 | | | |
| St. Dev. | 0.73 | 0.91 | | | |
| Min | 8.43 | 0.02 | | | |
| Max | 12.81 | 5.82 | | | |
| Summary Count | 96 | 96 | | | |
| Total Count | 96 | 96 | | | |

| | LLCR Delta Count by Category | | | | | | |
|-----------|------------------------------|---------------|--------------|-------------|--------------|-------|--|
| | Stable | Minor | Acceptable | Marginal | Unstable | Open | |
| mOhms | <=5 | >5.1 & <=10.0 | >10.1 & <=15 | >15.1& <=50 | >50 & <=1000 | >1000 | |
| Shock-Vib | 187 | 5 | 0 | 0 | 0 | 0 | |

Nanosecond Event Detection:

| Shock and Vibration Event Detection Summary | | | |
|---|---|--|--|
| Contacts tested | 60 | | |
| Test Condition | F, 40g's, 11ms, Half-Sine | | |
| Shock Events | 0 | | |
| Test Condition | V3 VITA 47.1, 12 G 'RMS', 5Hz to 2000Hz | | |
| Vibration Events | 0 | | |
| Total Events | 0 | | |

DATA SUMMARIES Continued

LLCR Non-Operating Class Temperature Group:

- 1) A total of 192 points were measured.
- 2) EIA-364-23, Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. <= +5.0 mOhms: -----Stable
 - b. +5.1 to +10 mOhms: -----Minor
 - c. +10.1 to +15.0 mOhms:-----Acceptable
 - d. +15.1 to +50.0 mOhms:-----Marginal
 - e. +50.1 to +1000 mOhms------Unstable
 - f. >+1000 mOhms:-----Open Failure

| | LLCR Measurement Summaries by Pin Type | | | |
|-------------------|--|----------------------|-----------------------|--|
| Date | 2/14/2019 | 2/27/2019 | 3/5/2019 | |
| Room Temp (Deg C) | 23 | 23 | 22 | |
| Rel Humidity (%) | 25 | 27 | 22 | |
| Technician | Tony Wagoner | Tony Wagoner | Joe Schoettmer | |
| mOhm values | Actual Initial | Delta Temp Cycle1 | Delta Temp Cycle 2 | |
| | Pin Type 1: Signal | | | |
| Average | 7.40 | 0.90 | 1.45 | |
| St. Dev. | 0.53 | 0.68 | 1.12 | |
| Min | 6.65 | 0.00 | 0.01 | |
| Max | 9.97 | 3.29 | 3.76 | |
| Summary Count | 192 | 192 | 192 | |
| Total Count | 192 | 192 | 192 | |

| | LLCR Delta Count by Category - Signal | | | | | | |
|--------------|---------------------------------------|---------------|--------------|-------------|--------------|-------|--|
| | Stable | Minor | Acceptable | Marginal | Unstable | Open | |
| mOhms | <=5 | >5.1 & <=10.0 | >10.1 & <=15 | >15.1& <=50 | >50 & <=1000 | >1000 | |
| Temp Cycle 1 | 192 | 0 | 0 | 0 | 0 | 0 | |
| Temp Cycle 2 | 192 | 0 | 0 | 0 | 0 | 0 | |

EQUIPMENT AND CALIBRATION SCHEDULES

Equipment #: TCT-04 Description: Dillon Quantrol TC21 25-1000 mm/min series test stand Manufacturer: Dillon Quantrol Model: TC2 I series test stand Serial #: 04-1041-04 Accuracy: Speed Accuracy: +/- 5% of indicated speed; Speed Accuracy: +/- 5% of indicated speed; ... Last Cal: 05/29/2018, Next Cal: 05/29/2019

Equipment #: MO-11 Description: Switch/Multimeter Manufacturer: Keithley Model: 3706 Serial #: 120169 Accuracy: See Manual ... Last Cal: 09/11/2018, Next Cal: 09/11/2019

Equipment #: THC-05 Description: Temperature/Humidity Chamber (Chamber Room) Manufacturer: Thermotron Model: SM-8-3800 Serial #: 05 23 00 02 Accuracy: See Manual ... Last Cal: 11/14/2018, Next Cal: 05/31/2019

Equipment #: TSC-01 Description: Vertical Thermal Shock Chamber Manufacturer: Cincinnati Sub Zero Model: VTS-3-6-6-SC/AC Serial #: 10-VT14993 Accuracy: See Manual ... Last Cal: 06/30/2018, Next Cal: 06/30/2019

Equipment #: HPT-01 Description: Hipot Safety Tester Manufacturer: Vitrek Model: V73 Serial #: 019808 Accuracy: ... Last Cal: 05/15/2018, Next Cal: 05/15/2019

Equipment #: OV-05 Description: Forced Air Oven, 5 Cu. Ft., 120 V (Chamber Room) Manufacturer: Sheldon Mfg. Model: CE5F Serial #: 02008008 Accuracy: +/- 5 deg. C ... Last Cal: 02/05/2019, Next Cal: 02/05/2020

EQUIPMENT AND CALIBRATION SCHEDULES

Equipment #: SVC-01 Description: Shock & Vibration Table Manufacturer: Data Physics Model: LE-DSA-10-20K Serial #: 10037 Accuracy: See Manual ... Last Cal: 04/22/2018, Next Cal: 04/22/2019

Equipment #: ACLM-01 Description: Accelerometer Manufacturer: PCB Piezotronics Model: 352C03 Serial #: 115819 Accuracy: See Manual ... Last Cal: 07/18/2018, Next Cal: 07/18/2019

Equipment #: ED-03 Description: Event Detector Manufacturer: Analysis Tech Model: 32EHD Serial #: 1100604 Accuracy: See Manual ... Last Cal: 10/31/2018, Next Cal: 10/31/2019